

Notice of References Cited	Application/Control No. 10/549,752	Applicant(s)/Patent Under Reexamination YANO, ATSUYOSHI	
	Examiner DEVONA E. FAULK	Art Unit 2615	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,485,543	01-1996	Aso, Takashi	704/267
*	B	US-5,963,901	10-1999	Vahatalo et al.	704/233
*	C	US-5,495,432	02-1996	Ho, Jyh-Chern	708/313
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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